

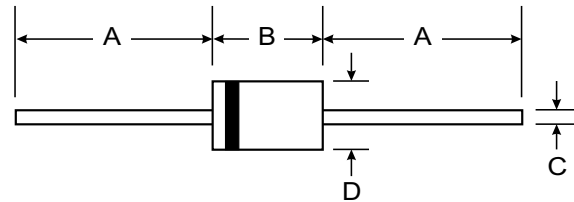
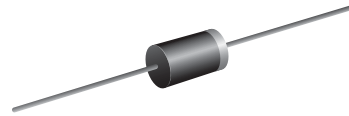
VOLTAGE RANGE: 50 - 1000V
CURRENT: 2.0 A

Features

- Diffused Junction
- Low Forward Voltage Drop
- High Current Capability
- High Reliability
- High Surge Current Capability

Mechanical Data

- Case: DO - 15 , Molded Plastic
- Terminals: Plated Leads Solderable per MIL-STD-202, Method 208
- Polarity: Cathode Band
- Weight: 0.40 grams (approx.)
- Mounting Position: Any
- Marking: Type Number



DO-15		
Dim	Min	Max
A	25.40	—
B	5.50	7.62
C	0.686	0.889
D	2.60	3.60
All Dimensions in mm		

Maximum Ratings and Electrical Characteristics @ $T_A=25^\circ\text{C}$ unless otherwise specified

Single Phase, half wave, 60Hz, resistive or inductive load. For capacitive load, derate current by 20%.

Characteristic	Symbol	UF200	UF201	UF202	UF204	UF205	UF206	UF208	UF2010	Unit	
Peak Repetitive Reverse Voltage Working Peak Reverse Voltage DC Blocking Voltage	V_{RRM} V_{RWM} V_R	50	100	200	300	400	600	800	1000	V	
RMS Reverse Voltage	$V_{R(RMS)}$	35	70	140	210	280	420	560	700	V	
Average Rectified Output Current (Note 1) @ $T_A = 55^\circ\text{C}$	I_O	2.0								A	
Non-Repetitive Peak Forward Surge Current 8.3ms Single half sine-wave superimposed on rated load (JEDEC Method)	I_{FSM}	60								A	
Forward Voltage @ $I_F = 2.0\text{A}$	V_{FM}	1.0			1.3		1.7			V	
Peak Reverse Current @ $T_A = 25^\circ\text{C}$ At Rated DC Blocking Voltage @ $T_A = 100^\circ\text{C}$	I_{RM}	5.0					100				μA
Reverse Recovery Time (Note 2)	t_{rr}	50					75				nS
Typical Junction Capacitance (Note 3)	C_j	60					40				pF
Operating Temperature Range	T_j	-65 to +125								$^\circ\text{C}$	
Storage Temperature Range	T_{STG}	-65 to +150								$^\circ\text{C}$	

Note: 1. Leads maintained at ambient temperature at a distance of 9.5mm from the case

2. Measured with $I_F = 0.5\text{A}$, $I_R = 1.0\text{A}$, $I_{RR} = 0.25\text{A}$. See figure 5.

3. Measured at 1.0 MHz and applied reverse voltage of 4.0V D.C.



RATING AND CHARACTERISTIC CURVES UF200 THRU UF2010

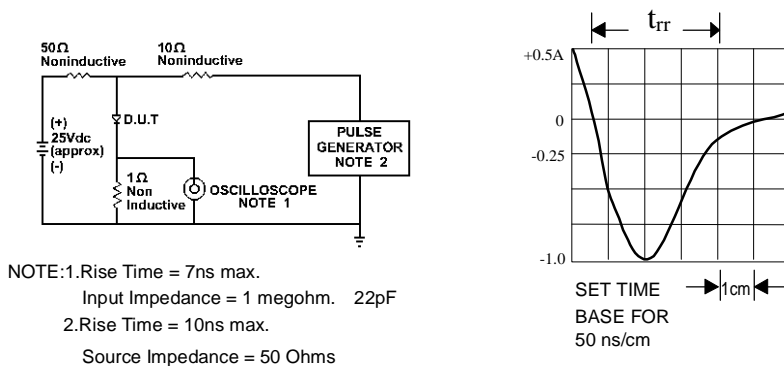


Fig. 1-REVERSE RECOVERY TIME CHARACTERISTIC AND TEST CIRCUIT DIAGRAM

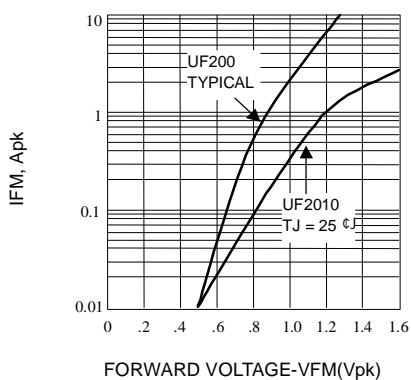


Fig. 2-FORWARD CHARACTERISTICS

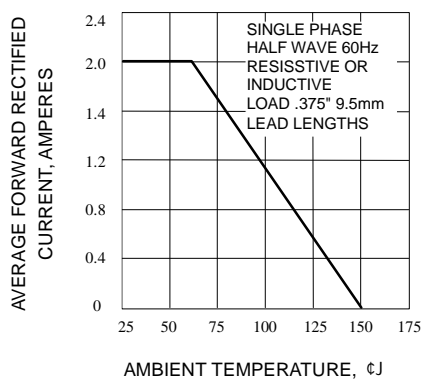


Fig. 3-FORWARD CURRENT DERATING CURVE

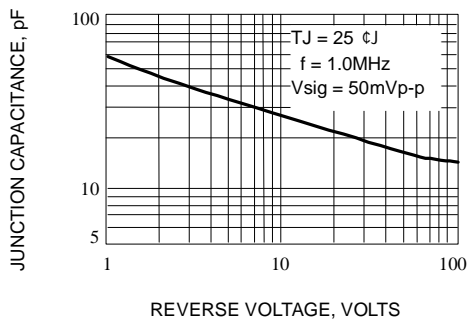


Fig. 4-TYPICAL JUNCTION CAPACITANCE

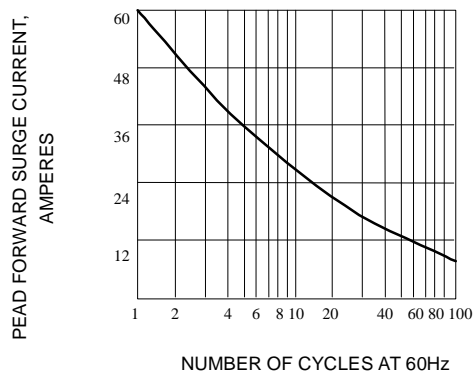


Fig. 5-PEAK FORWARD SURGE CURRENT